

# ADG528A/ADG529A—SPECIFICATIONS

## DUAL SUPPLY ( $V_{DD} = +10.8\text{ V to }+16.5\text{ V}$ , $V_{SS} = -10.8\text{ V to }-16.5\text{ V}$ , unless otherwise noted.)

Parameter	ADG528A ADG529A K Version -40°C to +25°C +85°C		ADG528A ADG529A B Version -40°C to +25°C +85°C		ADG528A ADG529A T Version -55°C to +25°C +125°C		Units	Comments
	$V_{SS}$	$V_{DD}$	$V_{SS}$	$V_{DD}$	$V_{SS}$	$V_{DD}$		
ANALOG SWITCH								
Analogue Signal Range	$V_{SS}$	$V_{DD}$	$V_{SS}$	$V_{DD}$	$V_{SS}$	$V_{DD}$	V min V max	
$R_{ON}$	280		280		280		$\Omega$ typ	$-10\text{ V} \leq V_S \leq +10\text{ V}$ , $I_{DS} = 1\text{ mA}$ ; Test Circuit 1
	450	600	450	600	450	600	$\Omega$ max	
	300	400	300	400			$\Omega$ max	$V_{DD} = 15\text{ V} (\pm 10\%)$ , $V_{SS} = -15\text{ V} (\pm 10\%)$
$R_{ON}$ Drift					300	400	$\Omega$ max	$V_{DD} = 15\text{ V} (\pm 5\%)$ , $V_{SS} = -15\text{ V} (\pm 5\%)$
$R_{ON}$ Match	0.6		0.6		0.6		%/°C typ	$-10\text{ V} \leq V_S \leq +10\text{ V}$ , $I_{DS} = 1\text{ mA}$
$I_S$ (OFF), Off Input Leakage	5		5		5		% typ	$-10\text{ V} \leq V_S \leq +10\text{ V}$ , $I_{DS} = 1\text{ mA}$
$I_D$ (OFF), Off Input Leakage	0.02		0.02		0.02		nA typ	$V1 = \pm 10\text{ V}$ , $V2 = \mp 10\text{ V}$ ; Test Circuit 2
	1	50	1	50	1	50	nA max	
$I_D$ (ON), On Channel Leakage	0.04		0.04		0.04		nA typ	$V1 = \pm 10\text{ V}$ , $V2 = \mp 10\text{ V}$ ; Test Circuit 3
ADG528A	1	100	1	100	1	100	nA max	
ADG529A	1	50	1	50	1	50	nA max	
$I_D$ (ON), On Channel Leakage	0.04		0.04		0.04		nA typ	$V1 = \pm 10\text{ V}$ , $V2 = \mp 10\text{ V}$ ; Test Circuit 4
ADG528A	1	100	1	100	1	100	nA max	
ADG529A	1	50	1	50	1	50	nA max	
$I_{DIFF}$ , Differential Off Output Leakage (ADG529A only)		25		25		25	nA max	$V1 = \pm 10\text{ V}$ , $V2 = \mp 10\text{ V}$ ; Test Circuit 5
DIGITAL CONTROL								
$V_{INH}$ , Input High Voltage		2.4		2.4		2.4	V min	
$V_{INL}$ , Input Low Voltage		0.8		0.8		0.8	V max	
$I_{INL}$ or $I_{INH}$		1		1		1	$\mu\text{A}$ max	$V_{IN} = 0$ to $V_{DD}$
$C_{IN}$ Digital Input Capacitance		8		8		8	pF max	
DYNAMIC CHARACTERISTICS <sup>1</sup>								
$t_{TRANSITION}$	200		200		200		ns typ	$V1 = \pm 10\text{ V}$ , $V2 = \mp 10\text{ V}$ ; Test Circuit 6
	300	400	300	400	300	400	ns max	
$t_{OPEN}$	50		50		50		ns typ	Test Circuit 7
	25	10	25	10	25	10	ns min	
$t_{ON}$ (EN, $\overline{WR}$ )	200		200		200		ns typ	Test Circuits 8 and 9
	300	400	300	400	300	400	ns max	
$t_{OFF}$ (EN, $\overline{RS}$ )	200		200		200		ns typ	Test Circuits 8 and 10
	300	400	300	400	300	400	ns max	
$t_W$ Write Pulse Width	100	120	100	120	100	130	ns min	See Figure 1
$t_S$ Address, Enable Setup Time		100		100		100	ns min	See Figure 1
$t_H$ Address, Enable Hold Time		10		10		10	ns min	See Figure 1
$t_{RS}$ Reset Pulse Width		100		100		100	ns min	See Figure 2
OFF Isolation	68		68		68		dB typ	$V_{EN} = 0.8\text{ V}$ , $R_L = 1\text{ k}\Omega$ , $C_L = 15\text{ pF}$ ,
	50		50		50		dB min	$V_S = 7\text{ V rms}$ , $f = 100\text{ kHz}$
$C_S$ (OFF)	5		5		5		pF typ	$V_{EN} = 0.8\text{ V}$
$C_D$ (OFF)								
ADG528A	22		22		22		pF typ	$V_{EN} = 0.8\text{ V}$
ADG529A	11		11		11		pF typ	
$Q_{INJ}$ , Charge Injection	4		4		4		pC typ	$R_S = 0\ \Omega$ , $V_S = 0\text{ V}$ ; Test Circuit 11

Parameter	ADG528A ADG529A K Version -40°C to +25°C +85°C		ADG528A ADG529A B Version -40°C to +25°C +85°C		ADG528A ADG529A T Version -55°C to +25°C +125°C		Units	Comments
	POWER SUPPLY							
I <sub>DD</sub>	0.6		0.6		0.6		mA typ	V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>
		1.5		1.5		1.5	mA max	
I <sub>SS</sub>	20		20		20		μA typ	V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>
		0.2		0.2		0.2	mA max	
Power Dissipation	10		10		10		mW typ	
		2.8		2.8		2.8	mW max	

**NOTE**

<sup>1</sup>Sample tested at +25°C to ensure compliance.

Specifications subject to change without notice.

## SINGLE SUPPLY (V<sub>DD</sub> = +10.8 V to +16.5 V, V<sub>SS</sub> = GND = 0 V, unless otherwise noted.)

Parameter	ADG528A ADG529A K Version -40°C to +25°C +85°C		ADG528A ADG529A B Version -40°C to +25°C +85°C		ADG528A ADG529A T Version -55°C to +25°C +125°C		Units	Comments
	ANALOG SWITCH							
Analog Signal Range	GND	GND	GND	GND	GND	GND	V min	
	V <sub>DD</sub>	V <sub>DD</sub>	V <sub>DD</sub>	V <sub>DD</sub>	V <sub>DD</sub>	V <sub>DD</sub>	V max	
R <sub>ON</sub>	500		500		500		Ω typ	GND ≤ V <sub>S</sub> ≤ +10 V, I <sub>DS</sub> = 0.5 mA; Test Circuit 1
	700	1000	700	1000	700	1000	Ω max	
R <sub>ON</sub> Drift	0.6		0.6		0.6		%/°C typ	GND ≤ V <sub>S</sub> ≤ +10 V, I <sub>DS</sub> = 0.5 mA
R <sub>ON</sub> Match	5		5		5		% typ	GND ≤ V <sub>S</sub> ≤ +10 V, I <sub>DS</sub> = 0.5 mA
I <sub>S</sub> (OFF), Off Input Leakage	0.02		0.02		0.02		nA typ	V1 = +10 V/GND, V2 = GND/+10 V;
	1	50	1	50	1	50	nA max	Test Circuit 2
I <sub>D</sub> (OFF), Off Input Leakage	0.04		0.04		0.04		nA typ	V1 = +10 V/GND, V2 = GND/+10 V;
ADG528A	1	100	1	100	1	100	nA max	Test Circuit 3
ADG529A	1	50	1	50	1	50	nA max	
I <sub>D</sub> (ON), On Channel Leakage	0.04		0.04		0.04		nA typ	V1 = +10 V/GND, V2 = GND/+10 V;
ADG528A	1	100	1	100	1	100	nA max	Test Circuit 4
ADG529A	1	50	1	50	1	50	nA max	
I <sub>DIFF</sub> , Differential Off Output Leakage (ADG529A only)		25		25		25	nA max	V1 = +10 V/GND, V2 = GND/+10 V; Test Circuit 5
DIGITAL CONTROL								
V <sub>INH</sub> , Input High Voltage		2.4		2.4		2.4	V min	
V <sub>INL</sub> , Input Low Voltage		0.8		0.8		0.8	V max	
I <sub>INL</sub> or I <sub>INH</sub>		1		1		1	μA max	V <sub>IN</sub> = 0 to V <sub>DD</sub>
C <sub>IN</sub> , Digital Input Capacitance	8		8		8		pF max	
DYNAMIC CHARACTERISTICS <sup>1</sup>								
t <sub>TRANSITION</sub>	300		300		300		ns typ	V1 = +10 V/GND, V2 = GND/+10 V; Test Circuit 6
	450	600	450	600	450	600	ns max	
t <sub>OPEN</sub>	50		50		50		ns typ	Test Circuit 7
	25	10	25	10	25	10	ns min	
t <sub>ON</sub> (EN, $\overline{\text{WR}}$ )	250		250		250		ns typ	Test Circuits 8 and 9
	450	600	450	600	450	600	ns max	
t <sub>OFF</sub> (EN, $\overline{\text{RS}}$ )	250		250		250		ns typ	Test Circuits 8 and 10
	450	600	450	600	450	600	ns max	
t <sub>W</sub> Write Pulse Width	100	120	100	120	100	130	ns min	See Figure 1

# ADG528A/ADG529A

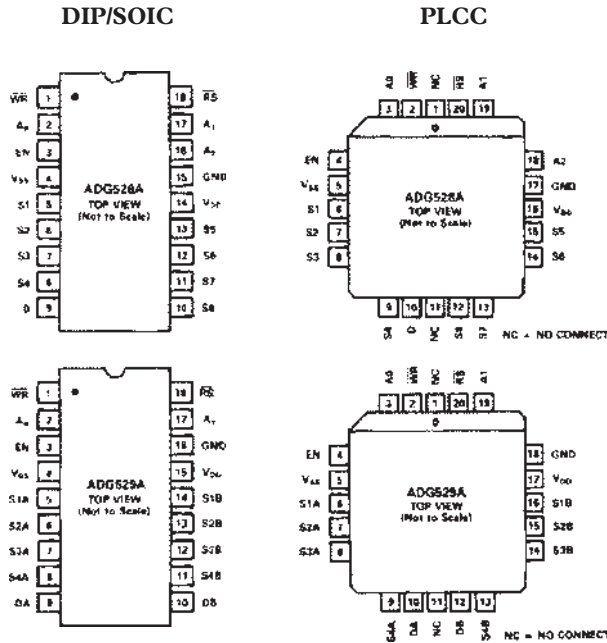
Parameter	ADG528A ADG529A K Version -40°C to +25°C +85°C	ADG528A ADG529A B Version -40°C to +25°C +85°C	ADG528A ADG529A T Version -55°C to +25°C +125°C	Units	Comments
DYNAMIC CHARACTERISTICS <sup>1</sup> (Cont'd)					
t <sub>S</sub> Address, Enable Setup Time	100	100	100	ns min	See Figure 1
t <sub>H</sub> Address, Enable Hold Time	10	10	10	ns min	See Figure 1
t <sub>RS</sub> Reset Pulse Width	100	100	100	ns min	See Figure 2
OFF Isolation	68	68	68	dB typ	V <sub>EN</sub> = 0.8 V, R <sub>L</sub> = 1 kΩ, C <sub>L</sub> = 15 pF,
	50	50	50	dB min	V <sub>S</sub> = 3.5 V rms, f = 100 kHz
C <sub>S</sub> (OFF)	5	5	5	pF typ	V <sub>EN</sub> = 0.8 V
C <sub>D</sub> (OFF)					
ADG528A	22	22	22	pF typ	V <sub>EN</sub> = 0.8 V
ADG529A	11	11	11	pF typ	
Q <sub>INJ</sub> , Charge Injection	4	4	4	pC typ	R <sub>S</sub> = 0 Ω, V <sub>S</sub> = 0 V; Test Circuit 11
POWER SUPPLY					
I <sub>DD</sub>	0.6	0.6	0.6	mA typ	V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>
	1.5	1.5	1.5	mA max	
Power Dissipation	11	10	10	mW typ	
	25	25	25	mW max	

## NOTE

<sup>1</sup>Sample tested at +25°C to ensure compliance.

Specifications subject to change without notice.

## PIN CONFIGURATIONS



## ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

(T<sub>A</sub> = +25°C, unless otherwise noted)

V<sub>DD</sub> to V<sub>SS</sub> ..... 44 V  
 V<sub>DD</sub> to GND ..... 25 V  
 V<sub>SS</sub> to GND ..... -25 V

Analog Inputs<sup>2</sup>  
 Voltage at S, D ..... V<sub>SS</sub> - 2 V to V<sub>DD</sub> + 2 V or 20 mA,  
 whichever Occurs First

Continuous Current, S or D ..... 20 mA  
 Pulsed Current, S or D

1 ms duration, 10% Duty Cycle ..... 40 mA

Digital Inputs<sup>1</sup>  
 Voltage at A, EN,  $\overline{WR}$ ,  $\overline{RS}$  ..... V<sub>SS</sub> - 4 V to V<sub>DD</sub> + 4 V or  
 20 mA, whichever Occurs First

Power Dissipation (Any Package)

Up to +75°C ..... 470 mW

Derates above +75°C ..... 6 mW/°C

Operating Temperature

Commercial (K Version) ..... -40°C to +85°C

Industrial (B Version) ..... -40°C to +85°C

Extended (T Version) ..... -55°C to +125°C

Storage Temperature Range ..... -65°C to +150°C

Lead Temperature (Soldering, 10 sec) ..... +300°C

## NOTES

<sup>1</sup>Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

<sup>2</sup>Overvoltage at A, EN,  $\overline{WR}$ ,  $\overline{RS}$ , S or D will be clamped by diodes. Current should be limited to the maximum rating above.

## ORDERING GUIDE

Model	Temperature Range	Package Description	Package Option <sup>1</sup>
ADG528AKN	-40°C to +85°C	PDIP	N-18
ADG528AKP	-40°C to +85°C	PLCC	P-20A
ADG528AKP-REEL	-40°C to +85°C	PLCC	P-20A
ADG528ABQ	-40°C to +85°C	CERDIP	Q-18
ADG528ATQ	-55°C to +125°C	CERDIP	Q-18
ADG528ABCHIPS		DIE	
ADG528ATCHIPS		DIE	
ADG529AKN	-40°C to +85°C	PDIP	N-18
ADG529AKP	-40°C to +85°C	PLCC	P-20A
ADG529AKRW	-40°C to +85°C	SOIC	RW-18
ADG529AKRW-REEL	-40°C to +85°C	SOIC	RW-18
ADG529AKRW-REEL7	-40°C to +85°C	SOIC	RW-18
ADG529ABQ	-40°C to +85°C	CERDIP	Q-18
ADG529ATQ	-55°C to +125°C	CERDIP	Q-18
ADG529ABCHIPS		DIE	
ADG529ATCHIPS		DIE	

## NOTES

<sup>1</sup>N = Plastic DIP; P = Plastic Leaded Chip Carrier (PLCC); Q = Cerdip; RW = SOIC.

## CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the ADG528A/ADG529A features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



# ADG528A/ADG529A

## TRUTH TABLES

A2	A1	A0	EN	$\overline{WR}$	$\overline{RS}$	ON SWITCH PAIR
X	X	X	X	1	1	Retains Previous Switch Condition
X	X	X	X	X	0	NONE (Address and Enable Latches Cleared)
X	X	X	0	0	1	NONE
0	0	0	1	0	1	1
0	0	1	1	0	1	2
0	1	0	1	0	1	3
0	1	1	1	0	1	4
1	0	0	1	0	1	5
1	0	1	1	0	1	6
1	1	0	1	0	1	7
1	1	1	1	0	1	8

X = Don't Care

ADG528A

A1	A0	EN	$\overline{WR}$	$\overline{RS}$	ON SWITCH PAIR
X	X	X	1	1	Retains Previous Switch Condition
X	X	X	X	0	NONE (Address and Enable Latches Cleared)
X	X	0	0	1	NONE
0	0	1	0	1	1
0	1	1	0	1	2
1	0	1	0	1	3
1	1	1	0	1	4

X = Don't Care

ADG529A

## TIMING DIAGRAMS

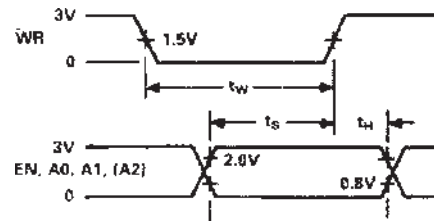


Figure 1.

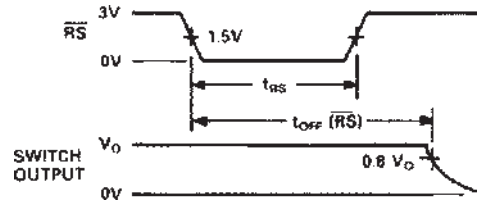


Figure 2.

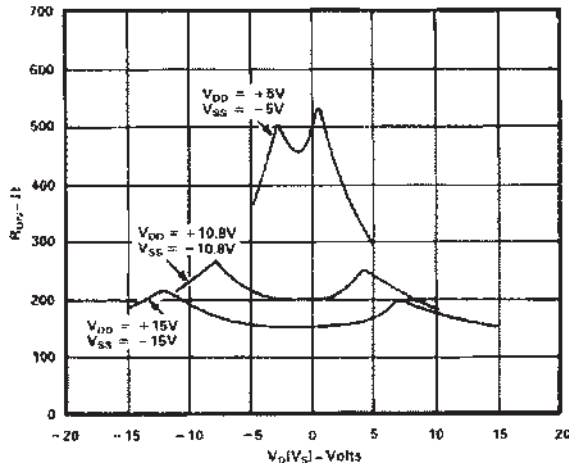
Figure 1 shows the timing sequence for latching the switch address and enable inputs. The latches are level sensitive; therefore, while  $\overline{WR}$  is held low, the latches are transparent and the switches respond to the address and enable inputs. This input data is latched on the rising edge of  $\overline{WR}$ .

Figure 2 shows the Reset Pulse Width,  $t_{RS}$ , and Reset Turn-off Time,  $t_{OFF}(\overline{RS})$ .

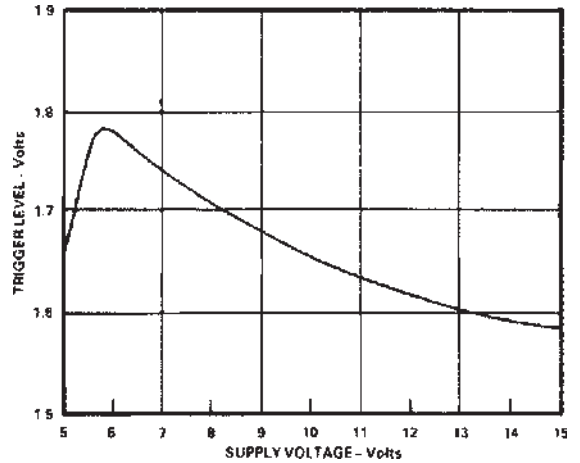
Note: All digital input signals rise and fall times measured from 10% to 90% of 3 V.  $t_R = t_F = 20$  ns.

# Typical Performance Characteristics—ADG528A/ADG529A

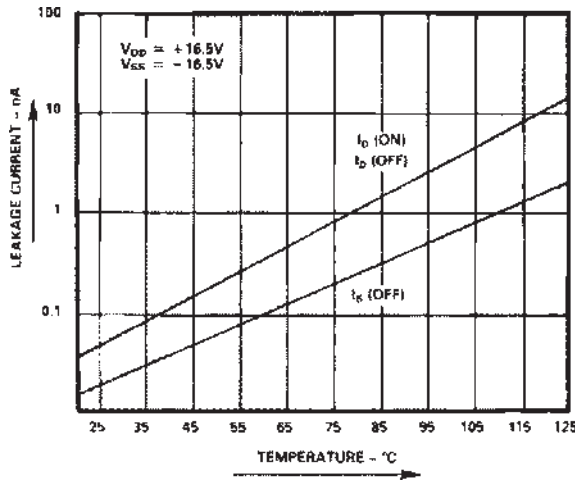
The multiplexers are guaranteed functional with reduced single or dual supplies down to 4.5 V.



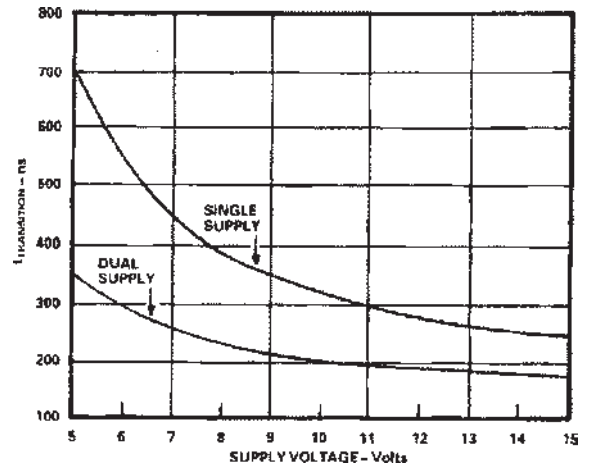
TPC 1.  $R_{ON}$  as a Function of  $V_D(V_S)$ : Dual Supply Voltage,  $T_A = +25^\circ C$



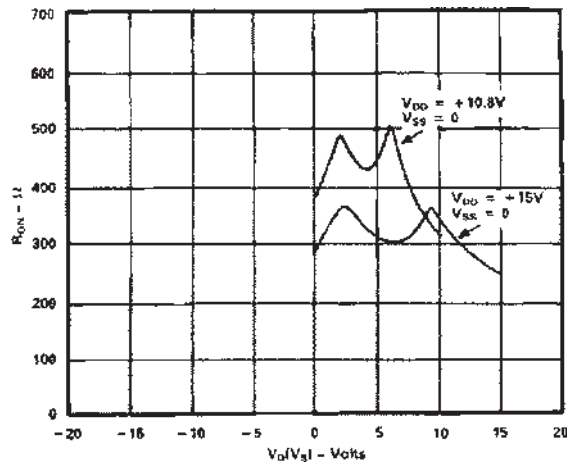
TPC 4. Trigger Levels vs. Power Supply Voltage, Dual or Single Supply,  $T_A = +25^\circ C$



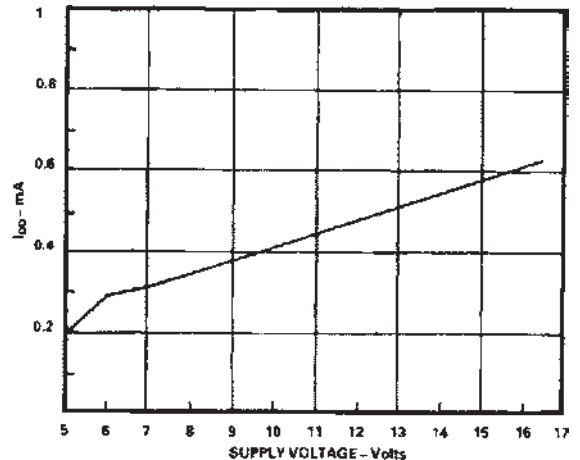
TPC 2. Leakage Current as a Function of Temperature (Note: Leakage Currents Reduce as the Supply Voltages Reduce)



TPC 5.  $t_{TRANSITION}$  vs. Supply Voltage: Dual and Single Supplies,  $T_A = +25^\circ C$  (Note: For  $V_{DD}$  and  $|V_{SS}| < 10 V$ ;  $V_1 = V_{DD}/V_{SS}$ ,  $V_2 = V_{SS}/V_{DD}$ . See Test Circuit 6)



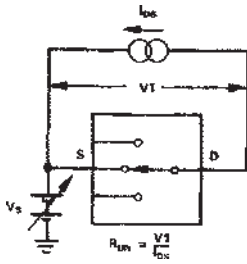
TPC 3.  $R_{ON}$  as a Function of  $V_D(V_S)$ : Single Supply Voltage,  $T_A = +25^\circ C$



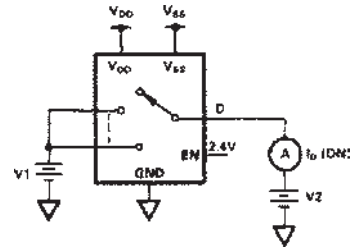
TPC 6.  $I_{DD}$  vs. Supply Voltage: Dual or Single Supply,  $T_A = +25^\circ C$

# ADG528A/ADG529A

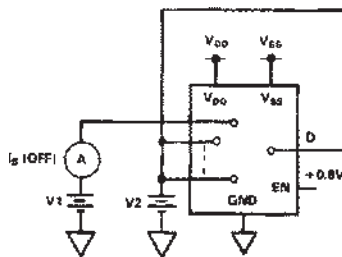
## Test Circuits



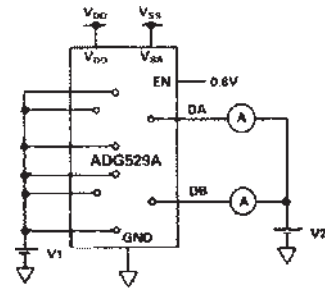
Test Circuit 1.  $R_{ON}$



Test Circuit 4.  $I_D$  (ON)

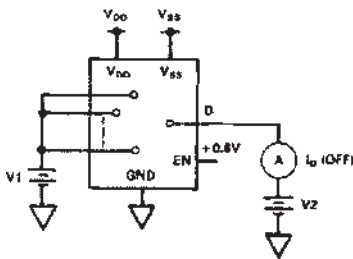


Test Circuit 2.  $I_S$  (OFF)

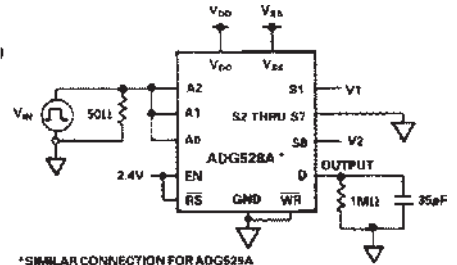
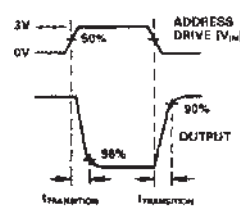


$$I_{DIFF} = I_{DA} (OFF) - I_{DB} (OFF)$$

Test Circuit 5.  $I_{DIFF}$

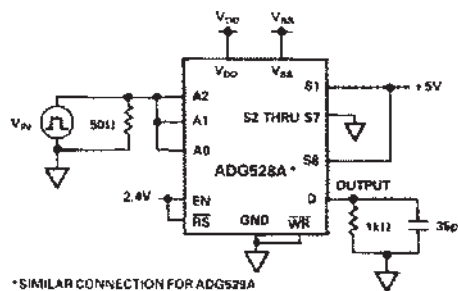
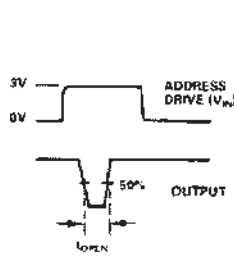


Test Circuit 3.  $I_D$  (OFF)



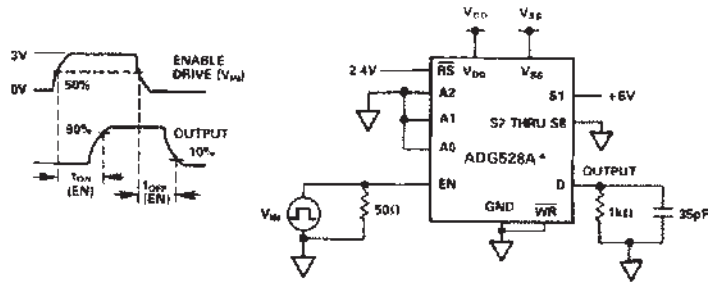
\*SIMILAR CONNECTION FOR ADG529A

Test Circuit 6. Switching Time of Multiplexer,  $t_{TRANSITION}$



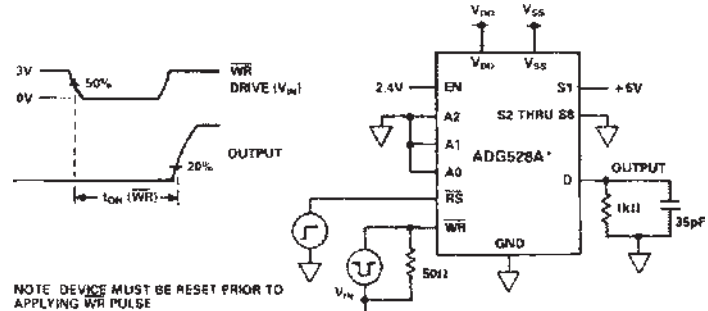
\*SIMILAR CONNECTION FOR ADG529A

Test Circuit 7. Break-Before-Make Delay,  $t_{OPEN}$



\*SIMILAR CONNECTION FOR ADG529A

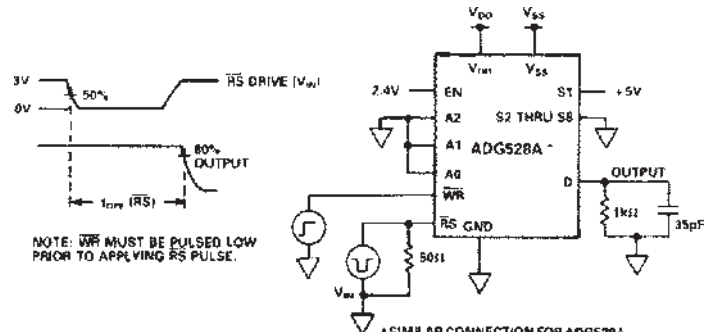
Test Circuit 8. Enable Delay,  $t_{ON}(EN)$ ,  $t_{OFF}(EN)$



NOTE: DEVICE MUST BE RESET PRIOR TO APPLYING WR PULSE

\*SIMILAR CONNECTION FOR ADG529A

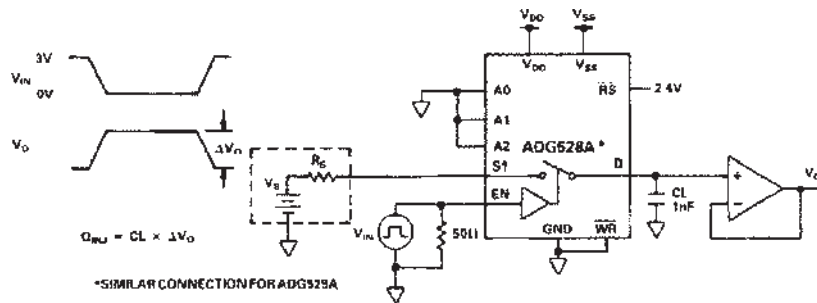
Test Circuit 9. Write Turn-On Time,  $t_{ON}(\overline{WR})$



NOTE: WR MUST BE PULSED LOW PRIOR TO APPLYING RS PULSE.

\*SIMILAR CONNECTION FOR ADG529A

Test Circuit 10. Reset Turn-Off Time,  $t_{OFF}(\overline{RS})$



\*SIMILAR CONNECTION FOR ADG529A

Test Circuit 11. Charge Injection

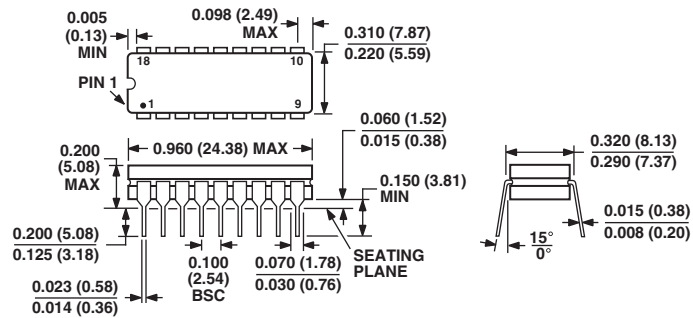




## OUTLINE DIMENSIONS

### 18-Lead Ceramic Dual In-Line Package [CERDIP] (Q-18)

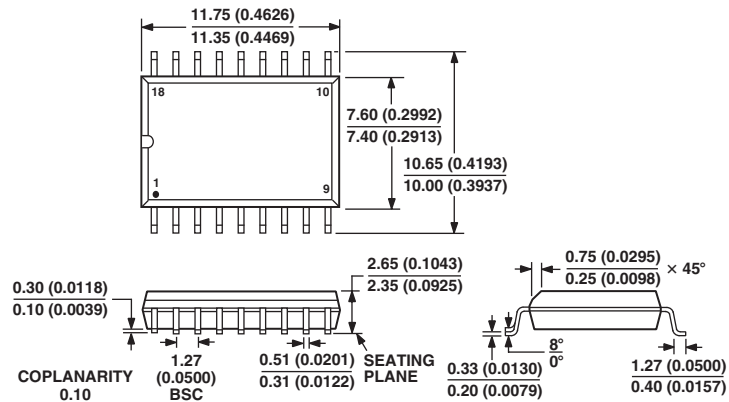
Dimensions shown in inches and (millimeters)



CONTROLLING DIMENSIONS ARE IN INCHES; MILLIMETER DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF INCH EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN

### 18-Lead Standard Small Outline Package [SOIC] Wide Body (RW-18)

Dimensions shown in millimeters and (inches)



COMPLIANT TO JEDEC STANDARDS MS-013AB  
CONTROLLING DIMENSIONS ARE IN MILLIMETERS; INCH DIMENSIONS (IN PARENTHESES) ARE ROUNDED-OFF MILLIMETER EQUIVALENTS FOR REFERENCE ONLY AND ARE NOT APPROPRIATE FOR USE IN DESIGN

# ADG528A/ADG529A

## Revision History

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<b>10/04—Data Sheet Changed from Rev. A to Rev. B</b>	
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